

SHEET 1 OF 1

Form PTO 1449 (Modified) LIST OF REFERENCES CITED BY APPLICANT		ATTY DOCKET NO. 219491US3		SERIAL NO. 10/073,910	
		APPLICANT Yoshinobu TAKANO			
		FILING DATE February 14, 2002		GROUP 2883	
		U.S. PATENT DOCUMENTS			
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS SUB CLASS
<i>BWV</i>	AA	5,930,438	07/27/1999	Göran PALMSKOG, et al.	385 /29
	AB				
	AC				
	AD				
	AE				
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	AN				
FOREIGN PATENT DOCUMENTS					
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO
<i>BWV</i>	AO	1229476A	09/22/1999	CHINA (with corr. WO98/12585A1 and US 5,930,438)	X
<i>BWV</i>	AP	WO98/12585A1	03/26/1998	WIPO (with partial English translation)	
	AQ				
	AR				
	AS				
	AT				
	AU				
	AV				
OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)					
<i>BWV</i>	AW	Patent Abstracts of China, CN 1257212A, December 14, 1998			
	AX				
	AY				
	AZ	<input type="checkbox"/> Additional References sheet(s) attached			
Examiner	<i>B. Healy</i>			Date Considered <i>3/10/05</i>	
*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.					

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LIST OF REFERENCES CITED BY APPLICANT		O I P E S C S OCT 18 2002 P A T E N T & T R A D E M A R K O F F I C E		APPLICANT Yoshinobu TANAKO	
		FILING DATE 02/14/02	GROUP 2883 2874		
U.S. PATENT DOCUMENTS					
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS 525 199
B M K	AA	5,783,636	07/21/98	KOIKE, et al.	525 199
B M K	AB	5,760,139	06/02/98	KOIKE, et al.	525 200
B M K	AC	6,271,312	08/08/01	KOIKE, et al.	525 199
B M K	AD	5,916,971	05/29/99	KOIKE, et al.	525 197
B M K	AE	6,071,441	06/06/00	KOGANEZAWA, et al.	264 1.24
B M K	AF	6,074,511	06/13/00	TAKANO, et al.	156 304.2
B M K	AG	6,225,382	05/01/01	MATSUKURA, et al.	524 100
B M K	AH	6,166,125	12/27/00	SUGIYAMA, et al.	524 462
B M K	AI	6,111,062	08/29/00	SHIROTA, et al.	528 402
B M K	AJ	6,221,987	04/24/01	SUGIYAMA	526 231
B M K	AK	6,448,452	09/10/02	KASHIWAGI, et al.	568 683
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	AM				
	AN				
FOREIGN PATENT DOCUMENTS					
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES NO
	AO				
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)					
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Examiner	<i>B. Healy</i>			Date Considered	<i>3/10/05</i>

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LIST OF REFERENCES CITED BY APPLICANT <i>O I P E</i> OCT 18 2002 PATENTS & TRADEMARKS		APPLICANT Yoshinobu TANAKO		FILING DATE 02/14/02		GROUP 2824 2883	
		U.S. PATENT DOCUMENTS					
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
M	AA	5,783,636	07/21/98	KOIKE, et al.	525	199	—
M	AB	5,760,139	06/02/98	KOIKE, et al.	525	200	—
M	AC	6,271,312	08/08/01	KOIKE, et al.	525	199	—
M	AD	5,916,971	05/29/99	KOIKE, et al.	525	197	—
M	AE	6,071,441	06/06/00	KOGANEZAWA, et al.	264	1.24	—
M	AF	6,074,511	06/13/00	TAKANO, et al.	156	304.2	—
M	AG	6,225,382	05/01/01	MATSUKURA, et al.	524	402 (100)	—
M	AH	6,166,125	12/27/00	SUGIYAMA, et al.	524	402	—
M	AI	6,111,062	08/29/00	SHIROTA, et al.	528	402	—
M	AJ	6,221,987	04/24/01	SUGIYAMA	526	231	—
M	AK	6,448,452	09/10/02	KASHIWAGI, et al.	568	683	—
	AL						
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES	NO	
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
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Examiner	<i>Hemang Singhani</i>				Date Considered <i>3/04/04</i>		
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LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Yoshinobu TAKANO			
				FILING DATE February 14, 2002		GROUP <i>2874 2883</i>	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>BWK</i>	AA	4,629,284	12/16/86	F.-L. MALAVIEILLE	<i>385</i>	<i>95X</i>	—
<i>BWK</i>	AB	4,871,227	10/03/89	W. TILSE	<i>385</i>	<i>95X</i>	—
<i>BWK</i>	AC	5,195,153	03/16/93	L. FINZEL	<i>385</i>	<i>70</i>	—
<i>BWK</i>	AD	4,779,954	10/25/88	Y. TATSUKAMI, et al.	<i>385</i>	<i>141X</i>	—
<i>BWK</i>	AE	5,692,089	11/25/97	G. J. SELLERS	<i>385</i>	<i>137</i>	—
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FOREIGN PATENT DOCUMENTS				(CLASS) <i>546-CL</i>			
		DOCUMENT NUMBER	DATE	COUNTRY	<i>385 95X</i>	TRANSLATION YES NO	
<i>BWK</i>	AO	0 065 096	11/24/82	EUROPE	<i>385 95X</i>		
	AP						
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
	AW						
	AX						
	AY						
	AZ					<input type="checkbox"/> Additional References sheet(s) attached	
Examiner <i>B. Henly</i>				Date Considered <i>3/10/05</i>			
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LIST OF REFERENCES CITED BY APPLICANT				APPLICANT Yoshinobu TAKANO			
				FILING DATE February 14, 2002		GROUP 2874	
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>m</i>	AA	4,629,284	12/16/86	F.-L. MALAIEILLE	385	95X	—
<i>m</i>	AB	4,871,227	10/03/89	W. TILSE	385	95X	—
<i>m</i>	AC	5,195,153	03/16/93	L. FINZEL	385	70	—
<i>m</i>	AD	4,779,954	10/25/88	Y. TATSUKAMI, et al.	385	141X	—
<i>m</i>	AE	5,692,089	11/25/97	G. J. SELLERS	385	137	—
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FOREIGN PATENT DOCUMENTS							
		DOCUMENT NUMBER	DATE	COUNTRY	CL	SUB CL	TRANSLATION YES NO
<i>m</i>	AO	0 065 096	11/24/82	EUROPE	385	95X	
	AP						
	AQ						
	AR						
	AS						
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	AU						
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
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	AZ						
		<input type="checkbox"/> Additional References sheet(s) attached					
Examiner <i>Hemant Sanghani</i>		Date Considered <i>3/4/04</i>					
<small>*Examiner: Initial if reference is considered, whether or not citation is in conformance with MPEP 609; Draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant.</small>							

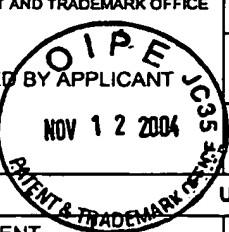
OCT 22 2002

Form PTO 1449 (Modified)		U.S. DEPARTMENT OF COMMERCE PATENT & TRADEMARK OFFICE		ATTY DOCKET NO. 219491US3	SERIAL NO. 10/073,910		
LIST OF REFERENCES CITED BY APPLICANT		APPLICANT Yoshinobu TAKANO					
		FILING DATE February 14, 2002		GROUP 2874 2883			
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>BW/H</i>	AA	5,963,699	10/05/99	T. TANAKA, et al.	385	9 7	—
	AB						
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		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION YES	NO	
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)							
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	AZ				<input type="checkbox"/> Additional References sheet(s) attached		
Examiner <i>B. Healy</i>		Date Considered <i>3/10/05</i>					
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OCT 22 2001 <small>U.S. DEPARTMENT OF COMMERCE PATENT & TRADEMARK OFFICE</small>		ATTY DOCKET NO. 219491US3		SERIAL NO. 10/073,910			
LIST OF REFERENCES CITED BY APPLICANT		APPLICANT Yoshinobu TAKANO					
		FILING DATE February 14, 2002		GROUP 2874 2883			
U.S. PATENT DOCUMENTS							
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
<i>AS</i>	AA	5,963,699	10/05/99	T. TANAKA, et al.	<i>385</i>	<i>97</i>	—
	AB						
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		DOCUMENT NUMBER	DATE	COUNTRY	TRANSLATION		
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<i>AZ</i>							
Examiner <i>Hemant Singh</i>		Date Considered <i>3/4/04</i>					
<input type="checkbox"/> Additional References sheet(s) attached							

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LIST OF REFERENCES CITED BY APPLICANT NOV 12 2004 O P E P A T E N T & T R A D E M A R K O F F I C E S C S		APPLICANT Yoshinobu TAKANO			
		FILING DATE February 14, 2002		GROUP 2883	
U.S. PATENT DOCUMENTS					
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME	CLASS SUB CLASS
AA					
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AL					
AM					
AN					
FOREIGN PATENT DOCUMENTS					
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS / SUB CLASS
<i>Burkitt</i>	AO	JP 8-5848	01/12/1996	Japan (with English Abstract)	385 / 147
	AP				
	AQ				
	AR				
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	AT				
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)					
	AW				
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	AZ			<input type="checkbox"/> Additional References sheet(s) attached	
Examiner	<i>S. Wray</i>			Date Considered <i>3/10/05</i>	
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				FILING DATE February 14, 2002		GROUP 2883		
U.S. PATENT DOCUMENTS								
EXAMINER INITIAL		DOCUMENT NUMBER	DATE	NAME		CLASS	SUB CLASS	FILING DATE IF APPROPRIATE
	AA							
	AB							
	AC							
	AD							
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	AN							
FOREIGN PATENT DOCUMENTS								
		DOCUMENT NUMBER	DATE	COUNTRY	CLASS	SUB-CL	TRANSLATION	
<i>SMW</i>	AO	JP 8-5848	01/12/1996	Japan (with English Abstract)	385	147	YES	NO
	AP							
	AQ							
	AR							
	AS							
	AT							
	AU							
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OTHER REFERENCES (Including Author, Title, Date, Pertinent Pages, etc.)								
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	AZ							<input type="checkbox"/> Additional References sheet(s) attached
Examiner		<i>S. I. [initials]</i>						Date Considered <i>3/10/05</i>

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